



STGP7NC60H - STGD7NC60H

N-CHANNEL 14A - 600V TO-220/DPAK

Very Fast PowerMESH™ IGBT

Table 1: General Features

| TYPE | V _{CES} | V _{CE(sat)} (Max) @25°C | I _C @100°C |
|--------------|------------------|-------------------------------------|--------------------------|
| STGP7NC60H | 600 V | < 2.5 V | 14 A |
| STGD7NC60HT4 | 600 V | < 2.5 V | 14 A |

- LOWER ON-VOLTAGE DROP (V_{cesat})
- OFF LOSSES INCLUDE TAIL CURRENT
- LOWER C_{RES}/C_{IES} RATIO
- HIGH FREQUENCY OPERATION UP TO 70 KHz
- NEW GENERATION PRODUCTS WITH TIGHTER PARAMETER DISTRIBUTION

DESCRIPTION

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "H" identifies a family optimized for high frequency applications in order to achieve very high switching performances (reduced t_{fall}) maintaining a low voltage drop.

APPLICATIONS

- HIGH FREQUENCY INVERTERS
- SMPS AND PFC IN BOTH HARD SWITCH AND RESONANT TOPOLOGIES
- MOTOR DRIVERS

Figure 1: Package

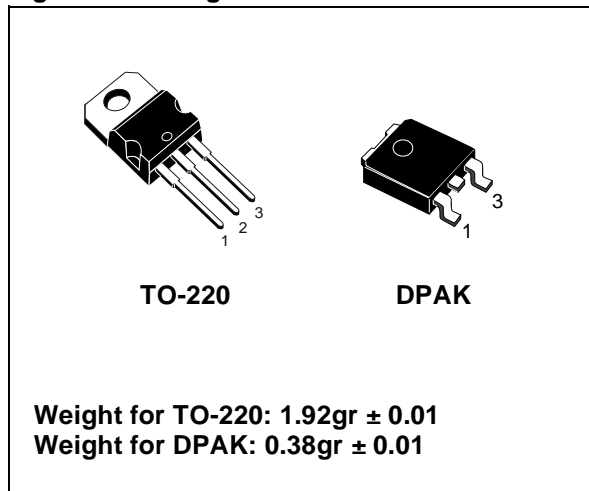


Figure 2: Internal Schematic Diagram

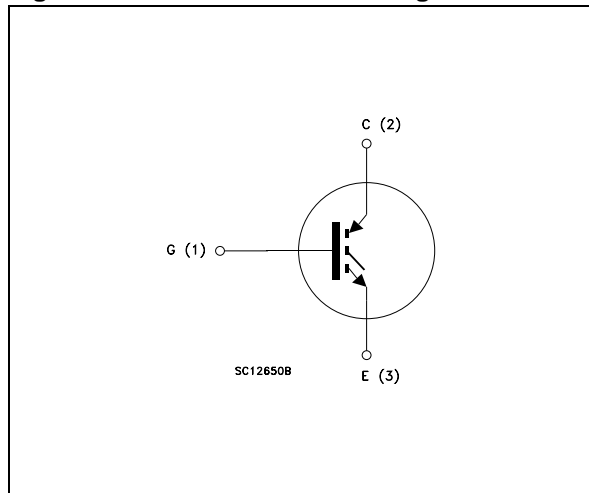


Table 2: Order Code

| PART NUMBER | MARKING | PACKAGE | PACKAGING |
|--------------|----------|---------|-------------|
| STGP7NC60H | GP7NC60H | TO-220 | TUBE |
| STGD7NC60HT4 | D7NC60H | DPAK | TAPE & REEL |

Table 3: Absolute Maximum ratings

| Symbol | Parameter | Value | | Unit |
|--------------------|---|-------------|------|---------------------|
| | | TO-220 | DPAK | |
| V_{CES} | Collector-Emitter Voltage ($V_{GS} = 0$) | 600 | | V |
| V_{ECR} | Emitter-Collector Voltage | 20 | | V |
| V_{GE} | Gate-Emitter Voltage | ± 20 | | V |
| I_C | Collector Current (continuous) at $T_C = 25^\circ\text{C}$ (#) | 25 | | A |
| I_C | Collector Current (continuous) at $T_C = 100^\circ\text{C}$ (#) | 14 | | A |
| $I_{CM} (\square)$ | Collector Current (pulsed) | 50 | | A |
| P_{TOT} | Total Dissipation at $T_C = 25^\circ\text{C}$ | 80 | 70 | W |
| | Derating Factor | 0.64 | 0.56 | W/ $^\circ\text{C}$ |
| T_{stg} | Storage Temperature | – 55 to 150 | | $^\circ\text{C}$ |
| T_j | Operating Junction Temperature | | | |

(\square) Pulse width limited by max. junction temperature.

Table 4: Thermal Data

| | | | Min. | Typ. | Max. | |
|-----------|--|--------|------|------|------|---------------------------|
| Rthj-case | Thermal Resistance Junction-case | TO-220 | | | 1.56 | $^\circ\text{C}/\text{W}$ |
| | | DPAK | | | 1.78 | |
| Rthj-amb | Thermal Resistance Junction-ambient | TO-220 | | | 62.5 | $^\circ\text{C}/\text{W}$ |
| | | DPAK | | | 100 | |
| T_L | Maximum Lead Temperature for Soldering Purpose (1.6 mm from case, for 10 sec.) | TO-220 | | 300 | | $^\circ\text{C}$ |
| | | DPAK | | 275 | | |

ELECTRICAL CHARACTERISTICS ($T_{CASE} = 25^\circ\text{C}$ UNLESS OTHERWISE SPECIFIED)
Table 5: Main Parameters

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---------------|---|--|------|-------------|-----------|---------------------|
| $V_{BR(CES)}$ | Collector-Emitter Breakdown Voltage | $I_C = 1\text{ mA}$, $V_{GE} = 0$ | 600 | | | V |
| I_{CES} | Collector cut-off Current ($V_{GE} = 0$) | $V_{CE} = \text{Max Rating}$, $T_C = 25^\circ\text{C}$ $V_{CE} = \text{Max Rating}$, $T_C = 125^\circ\text{C}$ | | | 10 1 | μA mA |
| I_{GES} | Gate-Emitter Leakage Current ($V_{CE} = 0$) | $V_{GE} = \pm 20\text{ V}$, $V_{CE} = 0$ | | | ± 100 | nA |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{CE} = V_{GE}$, $I_C = 250\text{ }\mu\text{A}$ | 3.75 | | 5.75 | V |
| $V_{CE(sat)}$ | Collector-Emitter Saturation Voltage | $V_{GE} = 15\text{ V}$, $I_C = 7\text{ A}$ $V_{GE} = 15\text{ V}$, $I_C = 7\text{ A}$, $T_C = 125^\circ\text{C}$ | | 1.85 1.7 | 2.5 | V V |

(#) Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C, I_C)}$$

ELECTRICAL CHARACTERISTICS (CONTINUED)**Table 6: Dynamic**

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------|---|---|------|---------------|------|----------------|
| g_{fs} (1) | Forward Transconductance | $V_{CE} = 15\text{ V}$, $I_C = 7\text{ A}$ | | 4.30 | | S |
| C_{ies} | Input Capacitance | $V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GE} = 0$ | | 720 | | pF |
| C_{oes} | Output Capacitance | | | 81 | | pF |
| C_{res} | Reverse Transfer Capacitance | | | 17 | | pF |
| Q_g Q_{ge} Q_{gc} | Total Gate Charge Gate-Emitter Charge Gate-Collector Charge | $V_{CE} = 390\text{ V}$, $I_C = 7\text{ A}$, $V_{GE} = 15\text{ V}$ (see Figure 21) | | 35 7 16 | 48 | nC nC nC |
| I_{CL} | Turn-Off SOA Minimum Current | $V_{clamp} = 480\text{ V}$, $T_J = 150^\circ\text{C}$ $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ | 50 | | | A |

(1) Pulsed: Pulse duration= 300 μs , duty cycle 1.5%**Table 7: Switching On**

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--|--|--|------|---------------------|------|------------------------------|
| $t_{d(on)}$ t_r $(di/dt)_{on}$ | Turn-on Delay Time Current Rise Time Turn-on Current Slope | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$ $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_J = 25^\circ\text{C}$ (see Figure 18) | | 18.5 8.5 1060 | | ns ns A/ μs |
| $t_{d(on)}$ t_r $(di/dt)_{on}$ | Turn-on Delay Time Current Rise Time Turn-on Current Slope | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$ $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_J = 125^\circ\text{C}$ (see Figure 19) | | 18.5 7 1000 | | ns ns A/ μs |

Table 8: Switching Off

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---|---|---|------|------------------|------|----------------|
| $t_r(V_{off})$ $t_{d(off)}$ t_f | Off Voltage Rise Time Turn-off Delay Time Current Fall Time | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ $T_J = 25^\circ\text{C}$ (see Figure 19) | | 27 72 60 | | ns ns ns |
| $t_r(V_{off})$ $t_{d(off)}$ t_f | Off Voltage Rise Time Turn-off Delay Time Current Fall Time | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$, $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$ $T_J = 125^\circ\text{C}$ (see Figure 19) | | 56 116 105 | | ns ns ns |

Table 9: Switching Energy

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|---|---|--|------|-------------------|-------------------|---|
| E_{on} (2) E_{off} (3) E_{ts} | Turn-on Switching Losses Turn-off Switching Loss Total Switching Loss | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$ $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_J = 25^\circ\text{C}$ (see Figure 19) | | 95 115 210 | 125 150 275 | μJ μJ μJ |
| E_{on} (2) E_{off} (3) E_{ts} | Turn-on Switching Losses Turn-off Switching Loss Total Switching Loss | $V_{CC} = 390\text{ V}$, $I_C = 7\text{ A}$ $R_G = 10\ \Omega$, $V_{GE} = 15\text{ V}$, $T_J = 125^\circ\text{C}$ (see Figure 19) | | 140 215 355 | | μJ μJ μJ |

2) E_{on} is the turn-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs & DIODE are at the same temperature (25°C and 125°C)

(3) Turn-off losses include also the tail of the collector current.

Figure 3: Output Characteristics

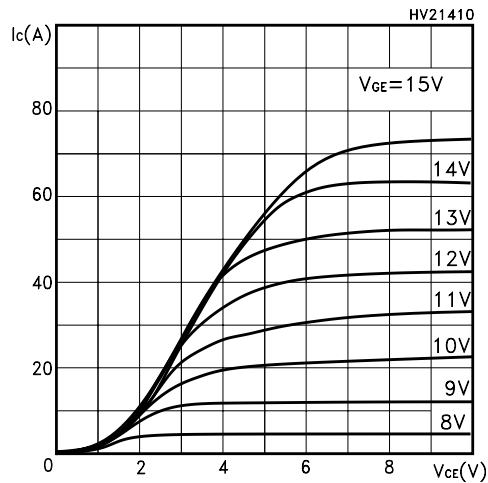


Figure 4: Transconductance

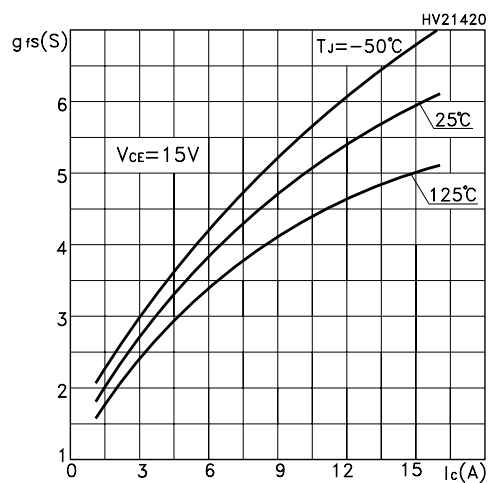


Figure 5: Collector-Emitter On Voltage vs Collector Current

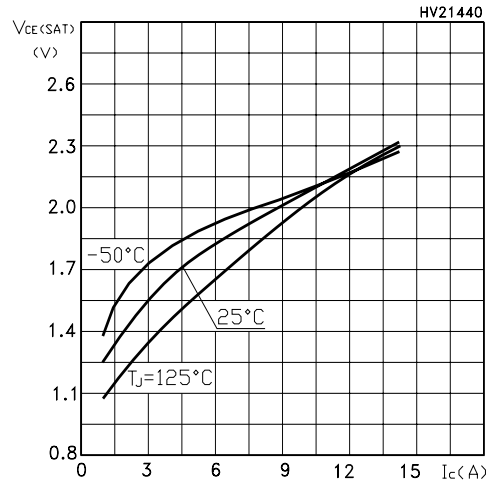


Figure 6: Transfer Characteristics

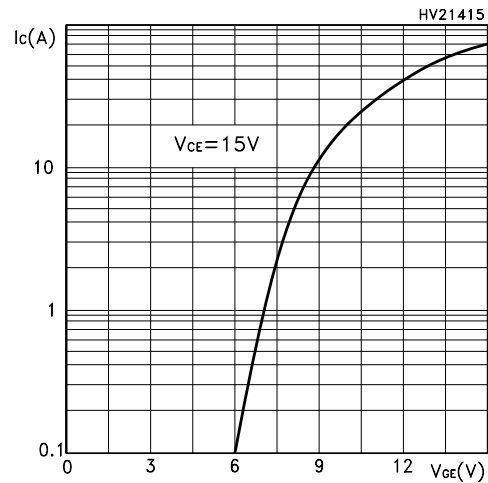


Figure 7: Collector-Emitter On Voltage vs Temperature

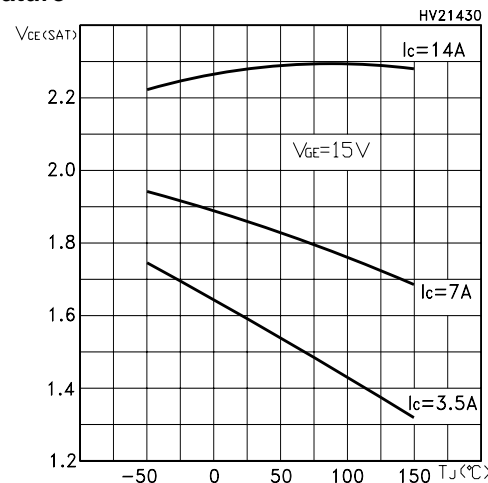


Figure 8: Normalized Gate Threshold vs Temperature

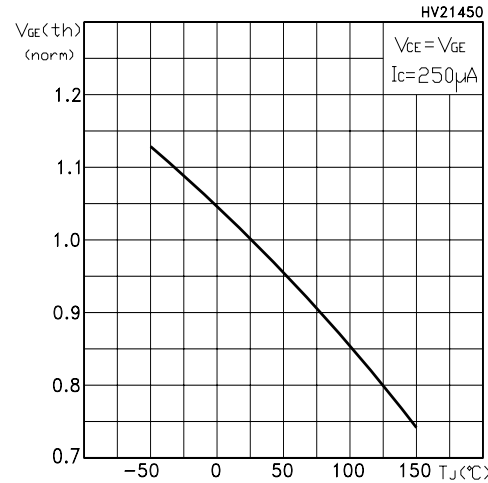


Figure 9: Normalized Breakdown Voltage vs Temperature

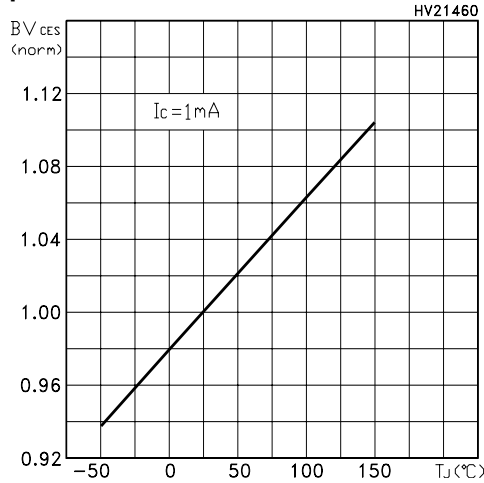


Figure 10: Capacitance Variations

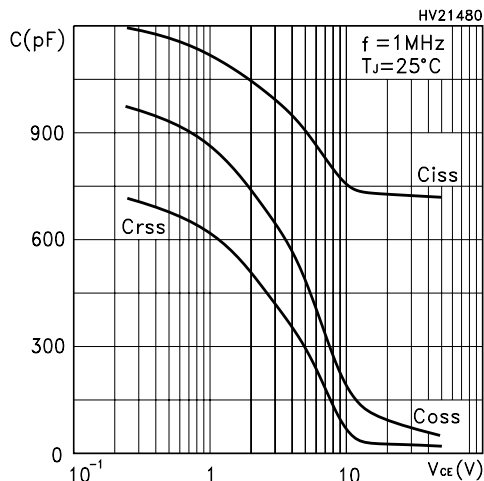


Figure 11: Total Switching Losses vs Gate Resistance

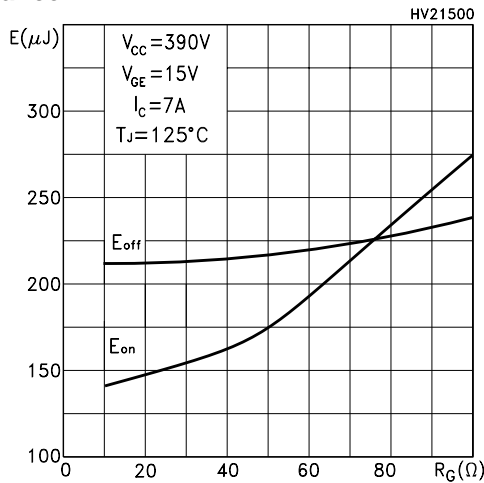


Figure 12: Gate Charge vs Gate-Emitter Voltage

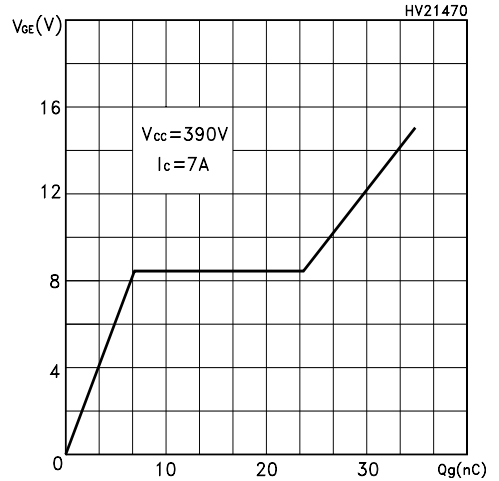


Figure 13: Total Switching Losses vs Temperature

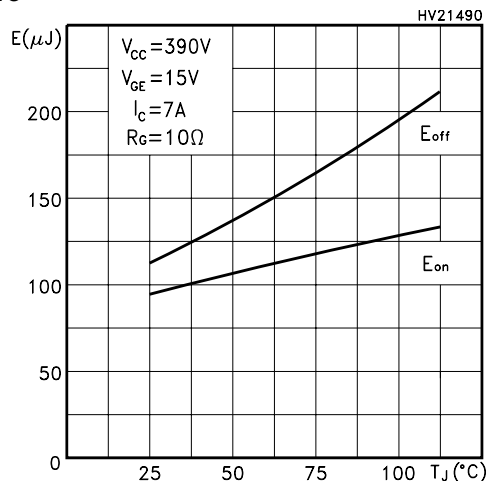


Figure 14: Total Switching Losses vs Collector Current

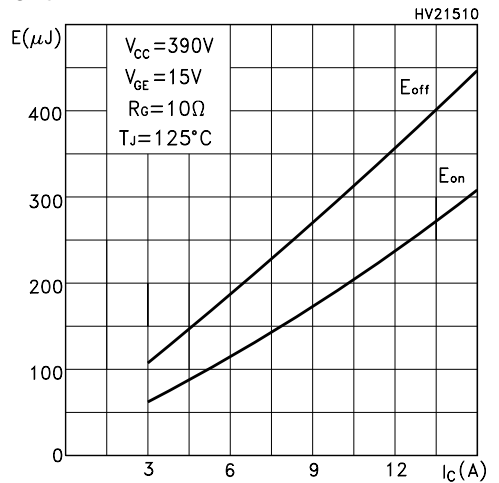


Figure 15: Thermal Impedance for TO-220

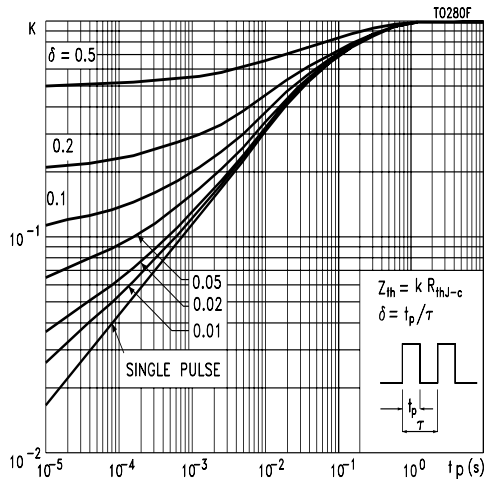


Figure 16: Thermal Impedance for DPAK

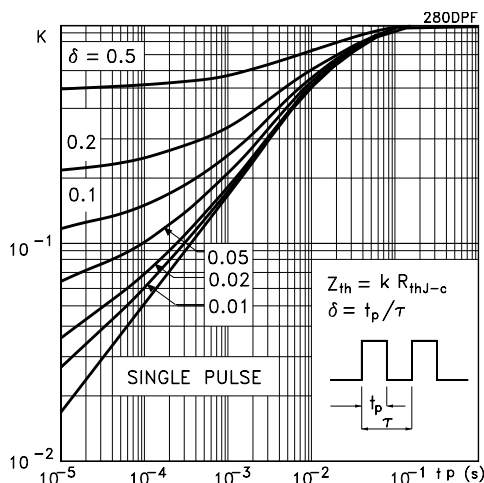


Figure 17: Turn-Off SOA

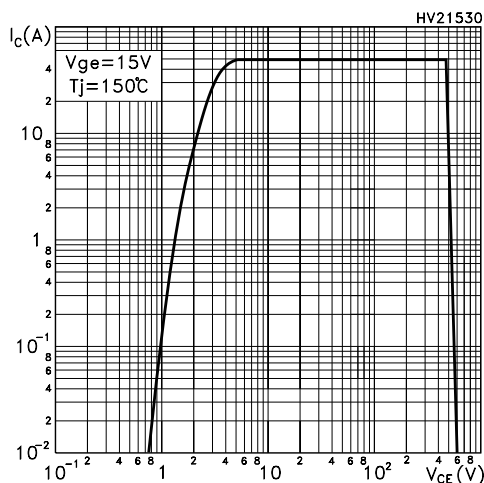
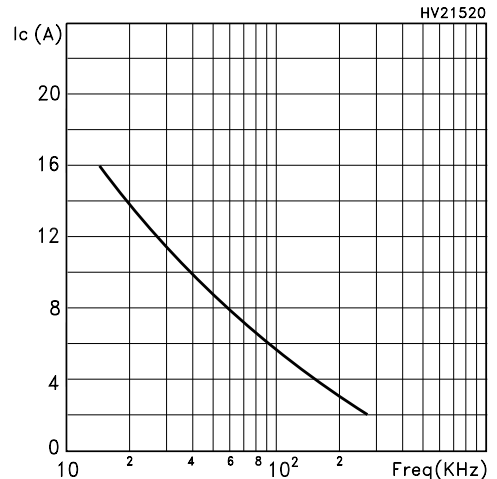


Figure 18: Ic vs Frequency



For a fast IGBT suitable for high frequency applications, the typical collector current vs. maximum operating frequency curve is reported. That frequency is defined as follows:

$$f_{MAX} = (P_D - P_C) / (E_{ON} + E_{OFF})$$

1) The maximum power dissipation is limited by maximum junction to case thermal resistance:

$$P_D = \Delta T / R_{THJ-C}$$

considering $\Delta T = T_J - T_C = 125^\circ\text{C} - 75^\circ\text{C} = 50^\circ\text{C}$

2) The conduction losses are:

$$P_C = I_C * V_{CE(SAT)} * \delta$$

with 50% of duty cycle, V_{CESAT} typical value @ 125°C .

3) Power dissipation during ON & OFF commutations is due to the switching frequency:

$$P_{SW} = (E_{ON} + E_{OFF}) * \text{freq.}$$

4) Typical values @ 125°C for switching losses are used (test conditions: $V_{CE} = 390\text{V}$, $V_{GE} = 15\text{V}$, $R_G = 3.3\text{ Ohm}$). Furthermore, diode recovery energy is included in the E_{ON} (see note 2), while the tail of the collector current is included in the E_{OFF} measurements (see note 3).

Figure 19: Test Circuit for Inductive Load Switching

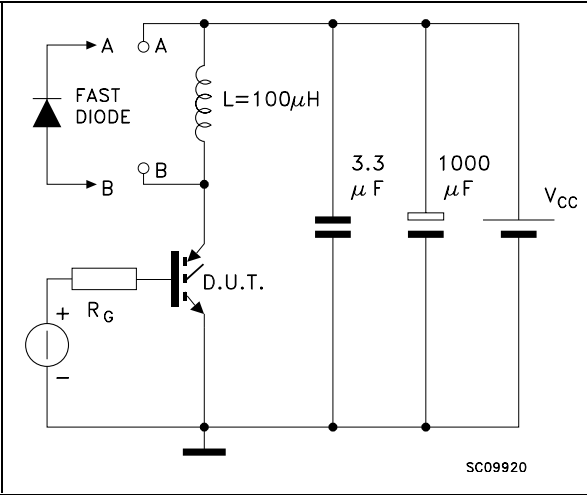


Figure 20: Switching Waveforms

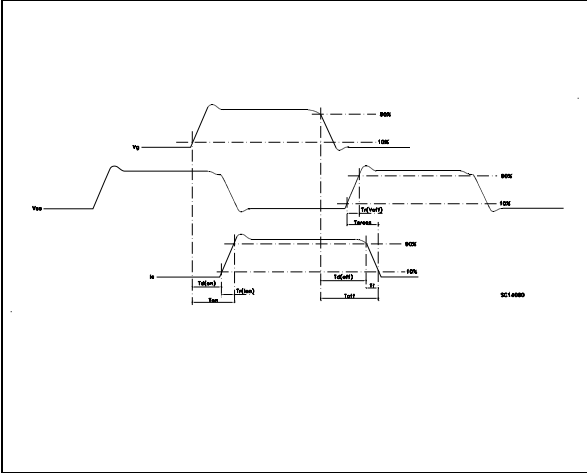
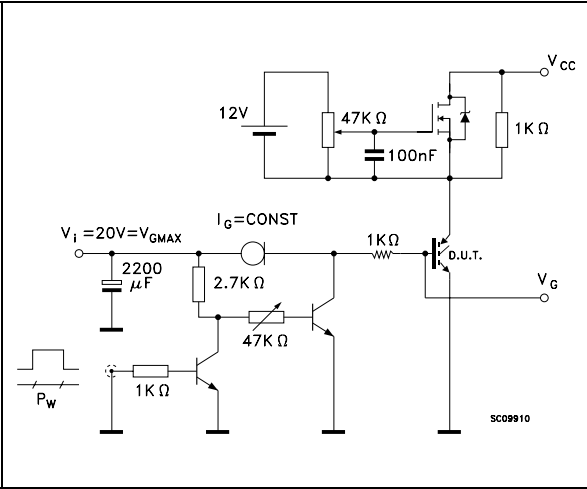
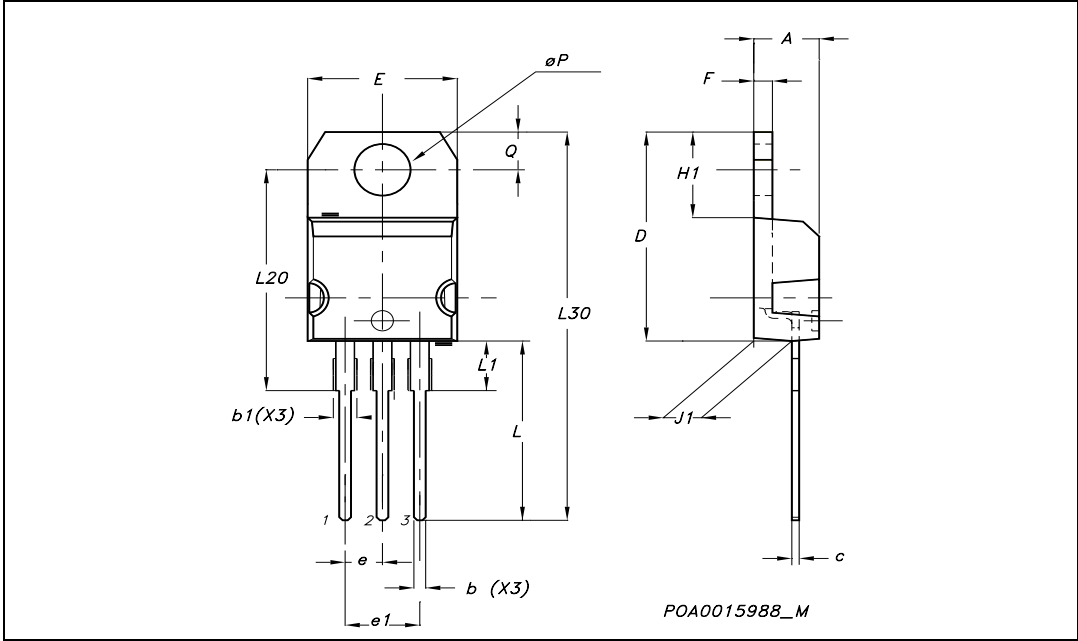


Figure 21: Gate Charge Test Circuit



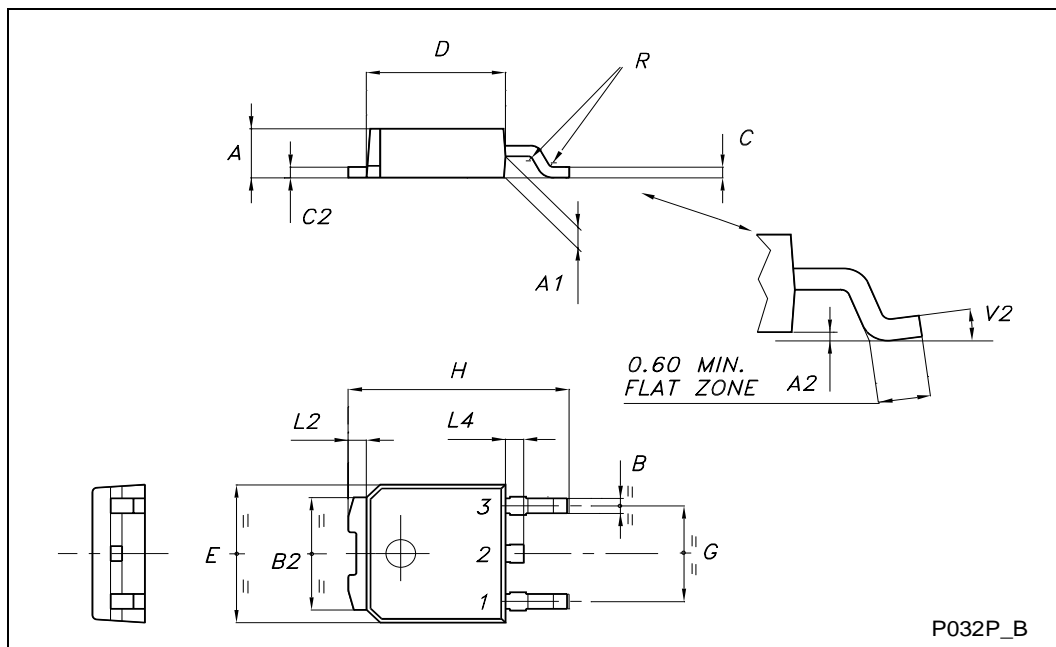
TO-220 MECHANICAL DATA

| DIM. | mm. | | | inch | | |
|------|-------|-------|-------|-------|-------|-------|
| | MIN. | TYP | MAX. | MIN. | TYP. | MAX. |
| A | 4.40 | | 4.60 | 0.173 | | 0.181 |
| b | 0.61 | | 0.88 | 0.024 | | 0.034 |
| b1 | 1.15 | | 1.70 | 0.045 | | 0.066 |
| c | 0.49 | | 0.70 | 0.019 | | 0.027 |
| D | 15.25 | | 15.75 | 0.60 | | 0.620 |
| E | 10 | | 10.40 | 0.393 | | 0.409 |
| e | 2.40 | | 2.70 | 0.094 | | 0.106 |
| e1 | 4.95 | | 5.15 | 0.194 | | 0.202 |
| F | 1.23 | | 1.32 | 0.048 | | 0.052 |
| H1 | 6.20 | | 6.60 | 0.244 | | 0.256 |
| J1 | 2.40 | | 2.72 | 0.094 | | 0.107 |
| L | 13 | | 14 | 0.511 | | 0.551 |
| L1 | 3.50 | | 3.93 | 0.137 | | 0.154 |
| L20 | | 16.40 | | | 0.645 | |
| L30 | | 28.90 | | | 1.137 | |
| øP | 3.75 | | 3.85 | 0.147 | | 0.151 |
| Q | 2.65 | | 2.95 | 0.104 | | 0.116 |

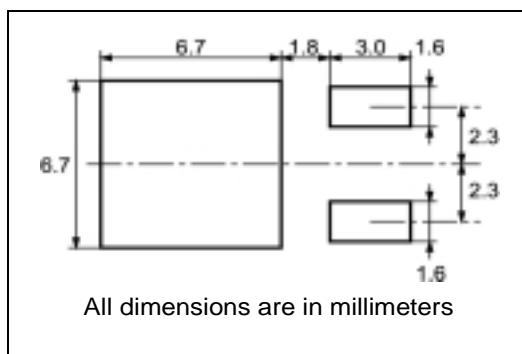


TO-252 (DPAK) MECHANICAL DATA

| DIM. | mm | | | inch | | |
|------|------|------|-------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | 2.20 | | 2.40 | 0.087 | | 0.094 |
| A1 | 0.90 | | 1.10 | 0.035 | | 0.043 |
| A2 | 0.03 | | 0.23 | 0.001 | | 0.009 |
| B | 0.64 | | 0.90 | 0.025 | | 0.035 |
| B2 | 5.20 | | 5.40 | 0.204 | | 0.213 |
| C | 0.45 | | 0.60 | 0.018 | | 0.024 |
| C2 | 0.48 | | 0.60 | 0.019 | | 0.024 |
| D | 6.00 | | 6.20 | 0.236 | | 0.244 |
| E | 6.40 | | 6.60 | 0.252 | | 0.260 |
| G | 4.40 | | 4.60 | 0.173 | | 0.181 |
| H | 9.35 | | 10.10 | 0.368 | | 0.398 |
| L2 | | 0.8 | | | 0.031 | |
| L4 | 0.60 | | 1.00 | 0.024 | | 0.039 |
| V2 | 0° | | 8° | 0° | | 0° |



DPAK FOOTPRINT



TAPE AND REEL SHIPMENT

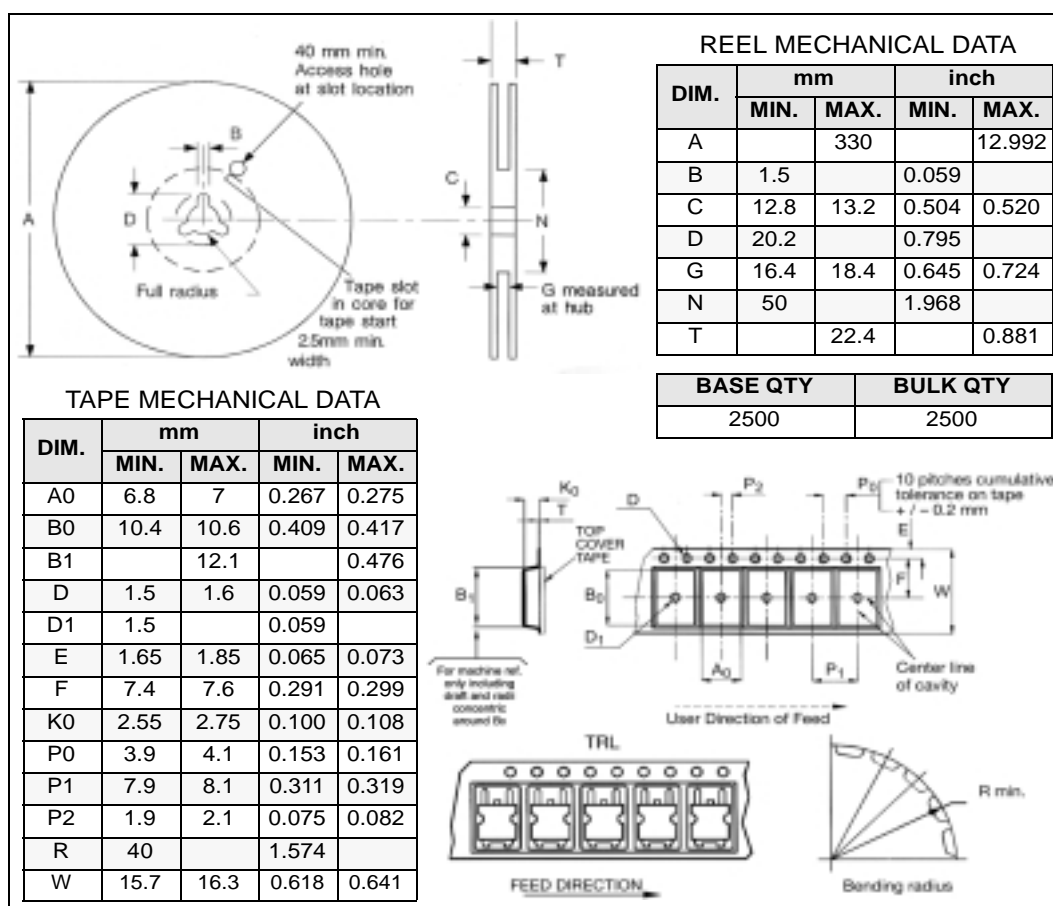


Table 10: Revision History

| Date | Revision | Description of Changes |
|-------------|----------|------------------------|
| 20-Aug-2004 | 1 | New datasheet |
| 09-Jun-2005 | 2 | Modified title |

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